

Notice of References Cited

Application/Control No.

10/593,790

Applicant(s)/Patent Under
Reexamination
MORGAN ET AL.

Examiner

DELIA M. RAMIREZ

Art Unit

1652

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Gubler et al., The EMBL Journal 11(1):233-240, 1992
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